

ILNAS

Institut luxembourgeois de la normalisation
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des produits et services

ILNAS-EN IEC 62969-3:2018

Semiconductor devices - Semiconductor interface for automotive vehicles - Part 3: Shock driven piezoelectric energy harvesting

Halbleiterbauelemente -
Halbleiterschnittstelle für Automobile -
Teil 3: Stoßgeführtes piezoelektrisches
Energie-Harvesting bei Sensoren für

Dispositifs à semiconducteurs - Interface
à semiconducteurs pour les véhicules
automobiles - Partie 3: Récupération de
l'énergie piézoélectrique produite par les



06/2018

National Foreword

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NORME EUROPÉENNE
EUROPÄISCHE NORM

June 2018

ICS 31.080.99

English Version

**Semiconductor devices - Semiconductor interface for automotive vehicles - Part 3: Shock driven piezoelectric energy harvesting for automotive vehicle sensors
(IEC 62969-3:2018)**

Dispositifs à semiconducteurs - Interface à semiconducteurs pour les véhicules automobiles - Partie 3: Récupération de l'énergie piézoélectrique produite par les chocs pour les capteurs de véhicules automobiles
(IEC 62969-3:2018)

Halbleiterbauelemente - Halbleiterschnittstelle für Automobile - Teil 3: Stoßgeführtes piezoelektrisches Energie-Harvesting bei Sensoren für Automobile
(IEC 62969-3:2018)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

European foreword

The text of document 47/2461/FDIS, future edition 1 of IEC 62969-3, prepared by IEC/TC 47 "Semiconductor devices" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62969-3:2018.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2019-03-11
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2021-06-11

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

- IEC 62047-5:2011 NOTE Harmonized as EN 62047-5:2011 (not modified).
IEC 62047-7:2011 NOTE Harmonized as EN 62047-7:2011 (not modified).

Annex ZA
(normative)

**Normative references to international publications
with their corresponding European publications**

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60749-5	-	Semiconductor devices - Mechanical and climatic test methods - Part 5: Steady-state temperature humidity bias life test	EN 60749-5	-
IEC 60749-10	-	Semiconductor devices - Mechanical and climatic test methods - Part 10: Mechanical shock	EN 60749-10	-
IEC 60749-12	-	Semiconductor devices - Mechanical and climatic test methods - Part 12: Vibration, variable frequency	EN IEC 60749-12	-
IEC 62830-1	-	Semiconductor devices - Semiconductor devices for energy harvesting and generation - Part 1: Vibration based piezoelectric energy harvesting	-	-



INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Semiconductor devices – Semiconductor interface for automotive vehicles –
Part 3: Shock driven piezoelectric energy harvesting for automotive vehicle
sensors**

**Dispositifs à semiconducteurs – Interface à semiconducteurs pour les véhicules
automobiles –
Partie 3: Récupération de l'énergie piézoélectrique produite par les chocs pour
les capteurs de véhicules automobiles**

CONTENTS

FOREWORD	4
INTRODUCTION	6
1 Scope	7
2 Normative references	7
3 Terms and definitions	7
3.1 General terms	8
3.2 Piezoelectric transducer	9
3.3 Characteristic parameters	10
4 Essential ratings and characteristic parameters	11
4.1 Identification and type	11
4.2 Limiting values and operating conditions	11
4.3 Additional information	12
5 Test method	12
5.1 General	12
5.2 Electrical characteristics	13
5.2.1 Test procedure	13
5.2.2 Capacitance	14
5.2.3 Natural frequency	14
5.2.4 Damping ratio	15
5.2.5 Output voltage	15
5.2.6 Output current	16
5.2.7 Output power	16
5.2.8 Optimal load impedance	17
5.2.9 Maximum output power	17
5.3 Mechanical characteristics	18
5.3.1 Test procedure	18
5.3.2 Temperature range	19
5.3.3 Shock magnitude	20
5.3.4 Temperature and humidity testing	20
5.3.5 Mechanical reliability (shock) testing	20
Annex A (informative) Mechanical shock pulses	21
Annex B (informative) Electromechanical coupling	23
B.1 Compliance and coupling coefficient relation	23
B.2 Young's modulus and coupling coefficient relation	23
Bibliography	24
 Figure 1 – Shock driven energy harvester using cantilever with piezoelectric film	8
Figure 2 – Conceptual diagram of shock driven piezoelectric energy harvester	9
Figure 3 – Equivalent circuit of shock driven piezoelectric energy harvester	10
Figure 4 – Measurement procedure of shock driven piezoelectric energy harvester	13
Figure 5 – Test setup for the electrical characteristics of shock driven piezoelectric energy harvester	14
Figure 6 – Output waveform and its frequency component of a shock driven piezoelectric energy harvester	15
Figure 7 – Output voltages of shock excited piezoelectric energy harvester at various external loads	16

Figure 8 – Output currents of shock driven piezoelectric energy harvester at various output voltages	16
Figure 9 – Output power of shock driven piezoelectric energy harvester at various external loads	17
Figure 10 – Output power and voltage of shock driven piezoelectric energy harvester at various shock amplitudes.....	18
Figure 11 – Block diagram of a test setup for evaluating the reliability of shock driven piezoelectric energy harvester	19
Figure A.1 – Comparison of general shock patterns and shock pattern from automobile	21
Figure A.2 – Impact (or shock) recorded by an electronic impact recorder	22
Table 1 – Specification parameters for shock driven piezoelectric energy harvesters	11